

FORM PTO-1449 U.S. Department of Commerce
Patent and Trademark Office

Attorney Docket Number
9236-3IP2

Serial No.
10/671,333

LIST OF DOCUMENTS CITED BY APPLICANT

(Use several sheets if necessary)

Applicants: Bantval J. Baliga

Filing Date: September 24, 2003

Group
2812

U. S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
9.5.	1.	6,541,820 B1	4/1/03	Bol	257	341	
	2.	6,534,836 B1	3/18/03	Osanai	257	401	
	3.	6,525,383 B1	2/25/03	Stecher	257	401	
	4.	6,521,962 B2	2/18/03	Evans	257	409	
	5.	6,503,786 B2	1/7/03	Klodzinski	438	212	
	6.	6,459,142 B1	10/1/02	Tihanyi	257	621	
	7.	6,452,230	9/17/02	Boden, Jr.	257	341	
	8.	6,441,408 B2	8/27/02	Porst	257	139	
	9.	6,201,279 B1	3/13/02	Pfirsch	257	333	
	10.	6,144,065	11/7/02	Kinzer	257	327	
	11.	6,127,746	10/3/00	Clemente	307	131	
	12.	6,114,726	9/5/00	Barkhordarian	257	341	
	13.	6,104,062	8/15/00	Zeng	257	341	
	14.	6,043,126	3/28/00	Kinzer	438	273	
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	19.	5,879,967	3/9/99	Kim	438	133	
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	21.	5,767,547	6/16/98	Merchant et al.	257	347	
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	23.	5,742,087	4/21/98	Lidow	257	342	
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28.	5,672,526	9/30/97	Kawamura	437	41R	
29.	5,661,314	8/26/97	Merrill	257	144	
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49.	5,216,807	6/8/93	Yoshizawa et al.	29	876	
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	61.	4,974,059	11/27/90	Kinzer	357	23.4	
	62.	4,959,699	9/25/90	Lidow et al.	357	23.7	
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	64.	4,904,614	2/27/90	Fisher et al.	437	41	
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9.5	76.	03132077	5/6/91	Japan			X (Abstract)

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<i>A.S.</i>	81.	Merchant et al., "Dependence of Breakdown Voltage on Drift Length and Buried Oxide Thickness in SOI RESURF LDMOS Transistors," 5 th International Symposium on Power Semiconductor Devices and Ics, 1993 IEEE, pp. 124-128						
<i>A.S.</i>	82.	Merchant et al., "Realization of High Breakdown Voltage (> 700 V) in This SOI Devices," Philips Laboratories, North American Philips Corporation, 1991 IEEE, pp. 31-35						
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